# **MOSFET** - Power, DUAL COOL® N-Channel, **DFN8 5x6**

40 V, 0.87 mΩ, 310 A

### **NVMFSCOD9N04C**

#### **Features**

- Advanced Dual-sided Cooled Packaging
- Small Footprint (5x6 mm) for Compact Design
- Ulra Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant
- MSL1 Robust Packaging Design

#### MAXIMUM RATINGS (T<sub>.J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	40	V
Gate-to-Source Voltage			$V_{GS}$	±20	V
Continuous Drain Current R <sub>θJC</sub> (Note 2)	Steady State	T <sub>C</sub> = 25°C	I <sub>D</sub>	313	Α
Power Dissipation R <sub>θJC</sub> (Note 2)			P <sub>D</sub>	166	W
Continuous Drain Current $R_{\theta JA}$ (Notes 1, 2)	Steady State	T <sub>A</sub> = 25°C	I <sub>D</sub>	48.9	Α
Power Dissipation R <sub>θJA</sub> (Notes 1, 2)			P <sub>D</sub>	4.1	W
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \ \mu s$		I <sub>DM</sub>	900	Α
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C
Source Current (Body Diode)			IS	158	Α
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 34 A)			E <sub>AS</sub>	578	mJ
Lead Temperature Soldering Reflow for Soldering Purposes (1/8" from case for 10 s)			TL	300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Bottom)- Steady State (Note 2)	$R_{\theta JC}$	0.9	°C/W
Junction-to-Case (Top) - Steady State (Note 2)	$R_{\theta JC}$	1.4	
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	37	

- Surface-mounted on FR4 board using a 1 in<sup>2</sup> pad size, 1 oz Cu pad.
- 2. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

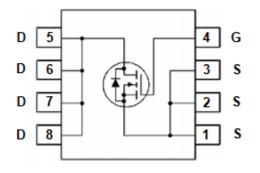


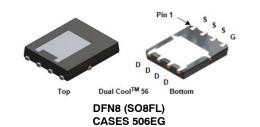
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#### www.onsemi.com

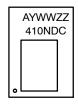
V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
40 V	0.87 m $\Omega$ @ 10 V	310 A

#### **N-Channel MOSFET**





#### MARKING DIAGRAM



410NDC = Specific Device Code

= Assembly Location Α

Υ = Year W = Work Week

ZZ = Lot Traceability

#### **ORDERING INFORMATION**

See detailed ordering, marking and shipping information on page 5 of this data sheet.

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V, } I_D = 250 \mu\text{A}$		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /	I <sub>D</sub> = 250 μA, ref to 25°C			5		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 40 V				10	μΑ
		$V_{DS} = 40 \text{ V}$ $T_{J} = 125^{\circ}\text{C}$	T <sub>J</sub> = 125°C			100	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = +20 V				100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = 250 \mu A$		2.5		3.5	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>	I <sub>D</sub> = 250 μA, ref	to 25°C		-8.6		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 50 A		0.69	0.87	mΩ
CHARGES & CAPACITANCES							
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 25 V			6100		pF
Output Capacitance	C <sub>OSS</sub>				3400		
Reverse Transfer Capacitance	C <sub>RSS</sub>				70		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 32 V; I <sub>D</sub> = 50 A			86		nC
Gate-to-Source Charge	$Q_{GS}$				28		
Gate-to-Drain Charge	$Q_{GD}$				14		
Plateau Voltage	$V_{GP}$				4.9		V
SWITCHING CHARACTERISTICS (Note 3)							
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS} = 10 \text{ V}, V_{DS} = 32 \text{ V},$ $I_{D} = 50 \text{ A}, R_{G} = 2.5 \Omega$			54		ns
Rise Time	t <sub>r</sub>	I <sub>D</sub> = 50 A, R <sub>G</sub> =	= 2.5 Ω		160		1
Turn-Off Delay Time	t <sub>d(OFF)</sub>				220		
Fall Time	t <sub>f</sub>				170		1
DRAIN-SOURCE DIODE CHARACTERISTICS	3						
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 50 A	$T_J = 25^{\circ}C$		0.8	1.2	V
			T <sub>J</sub> = 125°C		0.65		
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS}$ = 0 V, $dI_S/dt$ = 100 A/ $\mu$ s, $I_S$ = 50 A			91		ns
Charge Time	t <sub>a</sub>				42		7
Discharge Time	t <sub>b</sub>				49		1
Reverse Recovery Charge	Q <sub>RR</sub>				159		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**

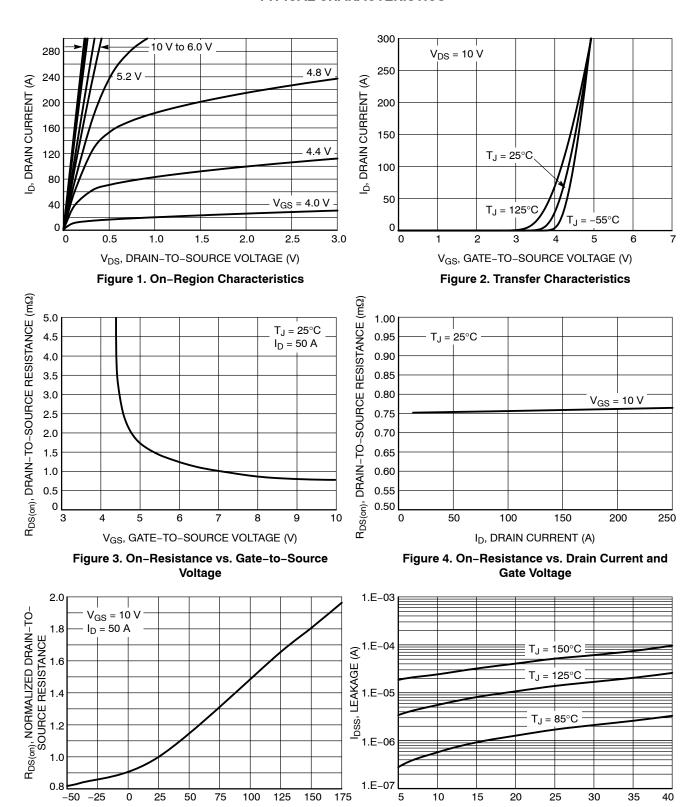


Figure 5. On–Resistance Variation with Temperature

T<sub>J</sub>, JUNCTION TEMPERATURE (°C)

Figure 6. Drain-to-Source Leakage Current vs. Voltage

V<sub>DS</sub>, DRAIN-TO-SOURCE VOLTAGE (V)

#### **TYPICAL CHARACTERISTICS**

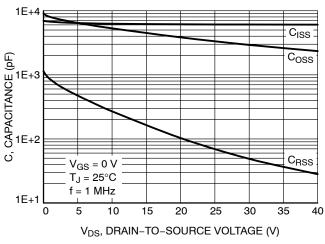


Figure 7. Capacitance Variation

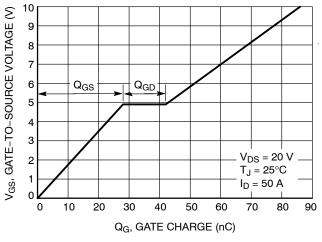


Figure 8. Gate-to-Source Voltage vs. Charge

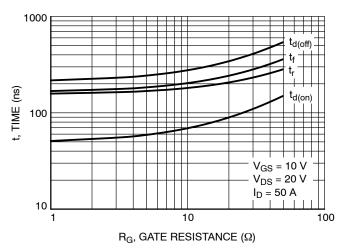


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

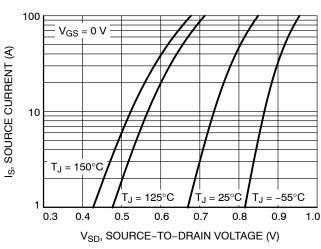


Figure 10. Diode Forward Voltage vs. Current

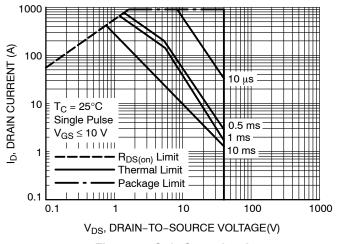


Figure 11. Safe Operating Area

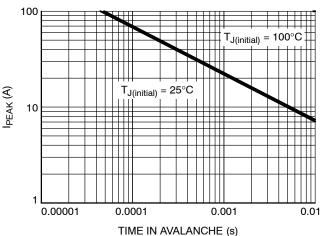


Figure 12. I<sub>PEAK</sub> vs. Time in Avalanche

#### **TYPICAL CHARACTERISTICS**

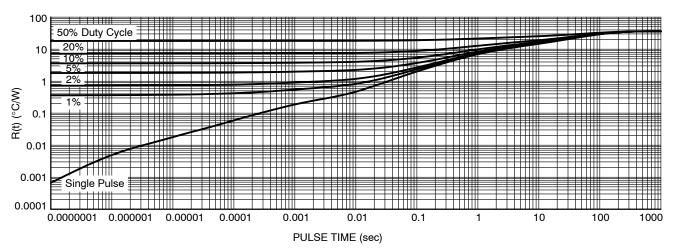


Figure 13. Thermal Characteristics

#### **ORDERING INFORMATION**

Device	Device Marking	Package	Shipping <sup>†</sup>
NVMFSC0D9N04C	410NDC	DFN8 5x6 (Pb-Free/Halogen Free)	3000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### DFN8 5x6.15, 1.27P, DUAL COOL CASE 506EG ISSUE D

**DATE 25 AUG 2020** 

MILL**I**METERS

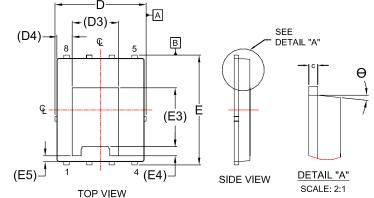
NOM.

0.90

MAX.

0.95

0.05



#### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
- 4. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
- 5. SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.

DIM

A A1

L1

θ

0.52

0°

0.62

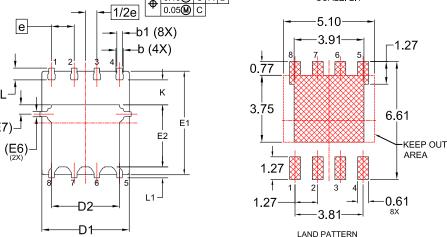
0.72

12°

MIN.

0.85

FRONT VIEW  SEE DETAIL "B"  8X  0.10	SEATING PLANE
0.10 <b>@</b> C A B	DETAIL "B"  SCALE: 2:1
e 1/2e	5.10



A2	-	-	0.05	
b	0.31	0.41	0.51	
b1	0.21	0.31	0.41	
С	0.20	0.25	0.30	
D	4.90	5.00	5.10	
D1	4.80	4.90	5.00	
D2	3.67	3.82	3.97	
D3		2.60 RE	F	
D4		0.86 RE	F	
Е	6.05	6.15	6.25	
E1	5.70	5.80	5.90	
E2	3.38	3.48	3.58	
E3	3.30 REF			
E4		0.50 REF	=	
E5	0.34 REF			
E6	0.30 REF			
E7	0.52 REF			
е	1.27 BSC			
1/2e	0.635 BSC			
K	1.30	1.40	1.50	
L	0.56	0.66	0.76	

# GENERIC MARKING DIAGRAM\*

**BOTTOM VIEW** 

XXXX = Specific Device Code A = Assembly Location

Y = Year WW = Work Week

ZZ = Assembly Lot Code

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

XXXXXX	

DOCUMENT NUMBER:	98AON84257G	Electronic versions are uncontrolled except when accessed directly from Printed versions are uncontrolled except when stamped "CONTROLLED"	
DESCRIPTION:	DFN8 5x6.15. 1.27P. DUAL	COOL	PAGE 1 OF 1

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